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U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
TWH	AA	5,645,868	07-1997	Reinhart, William A.	425	145	
TWH	AB	5,679,384	10-1997	Emoto, Atsushi	425	145	
TWH	AC	5,891,485	04-1999	Emoto, Atsushi	425	145	
TWH	AD	5,911,924	06-1999	Siegrist et al	264	40.1	
TWH	AE	6,394,780	05-2002	Hehl, Karl	425	145	
TWH	AF	6,517,336	02-2003	Emoto et al	425	145	
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TWH	AH	5,823,293	10-1998	Gilbertson et al	—	—	

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		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO PART.		
TWH	AI	EP 1 004 421 A1	05-2000	Europe	—	—			
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TWH	AK	JP 2000-71304 A	03-2000	Japan	—	—			
TWH	AL	DE 198 52 513 A1	06-1999	Germany	—	—			
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AW	
	AX	
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EXAMINER 		DATE CONSIDERED 11-29-05
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